

**Notice of References Cited**

Application/Control No.

09/987,064

Applicant(s)/Patent Under  
Reexamination  
KAWANO ET AL.

Examiner

John P. Sheehan

Art Unit

1742

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,395,459	03-1995	Pinkerton et al.	148/101
	B	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	P					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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